

- Package Options Include Plastic and Ceramic DIPs and Ceramic Flat Packages
- Dependable Texas Instruments Quality and Reliability

description

These monolithic, edge-triggered J-K flip-flops feature gated inputs, direct clear and preset inputs, and complementary Q and \bar{Q} outputs. Input information is transferred to the outputs on the positive edge of the clock pulse.

Direct-coupled clock triggering occurs at a specific voltage level of the clock pulse, and after the clock input threshold voltage has been passed, the gated inputs are locked out.

These flip-flops are ideally suited for medium-to-high-speed applications and can result in a significant saving in system power dissipation and package count where input gating is required.

The SN5470 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN7470 is characterized for operation from 0°C to 70°C .

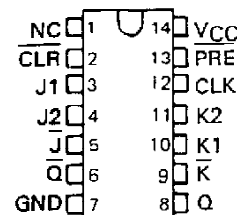
FUNCTION TABLE

INPUTS					OUTPUTS	
PRE	CLR	CLK	J	K	Q	\bar{Q}
L	H	L	X	X	H	L
H	L	L	X	X	L	H
L	L	X	X	X	L†	L†
H	H	↑	L	L	Q_0	\bar{Q}_0
H	H	↑	H	L	H	L
H	H	↑	L	H	L	H
H	H	↑	H	H	TOGGLE	
H	H	L	X	X	Q_0	\bar{Q}_0

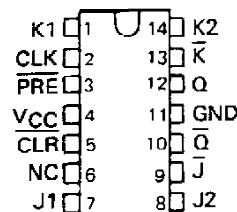
If inputs J and K are not used, they must be grounded. Preset or clear function can occur only when the clock input is low.

†This configuration is nonstable; that is, it will not persist when preset and clear inputs return to their inactive (high) level.

SN5470 . . . J PACKAGE
SN7470 . . . N PACKAGE
(TOP VIEW)

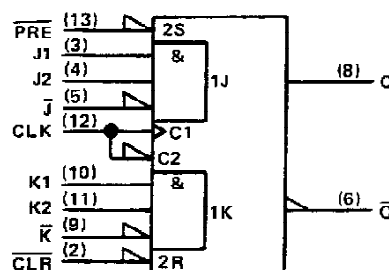


SN5470 . . . W PACKAGE
(TOP VIEW)



NC - No internal connection

logic symbol†



†This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

Pin numbers shown are for J and N packages only.

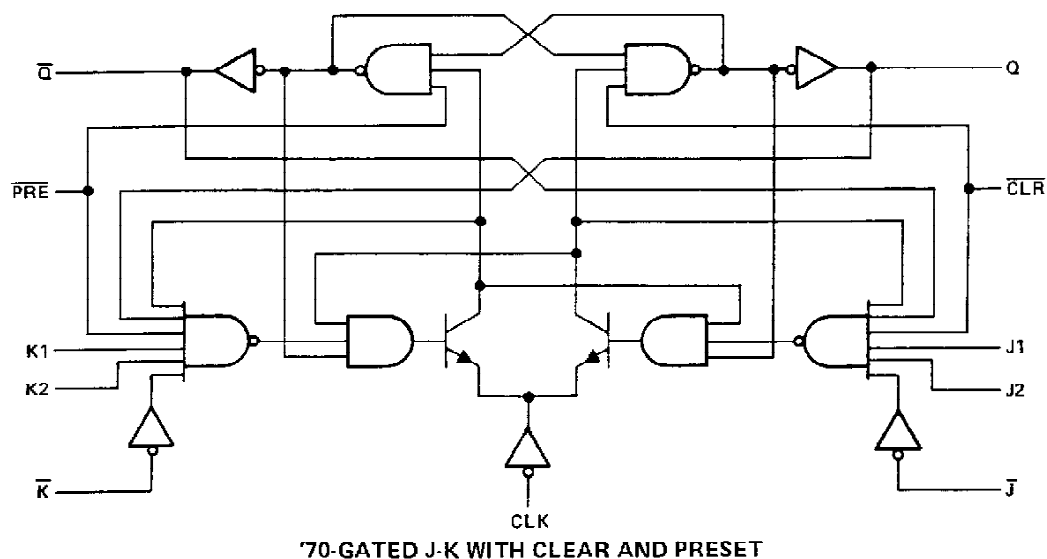
positive logic

$$J = J1 \cdot J2 \cdot \bar{J}$$

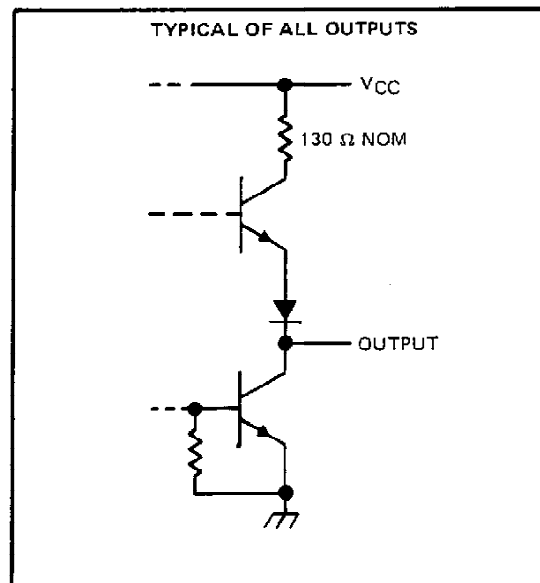
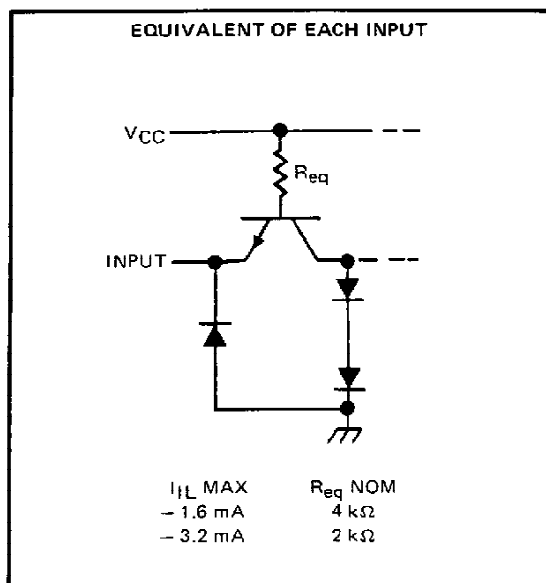
$$K = K1 \cdot K2 \cdot \bar{K}$$

SN5470, SN7470
AND-GATED J-K POSITIVE-EDGE-TRIGGERED
FLIP-FLOPS WITH PRESET AND CLEAR

logic diagram (positive logic)



schematics of input and outputs




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SN5470, SN7470

AND-GATED J-K POSITIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET AND CLEAR

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)	7 V
Input voltage	5.5 V
Operating free-air temperature: SN5470	– 55°C to 125°C
SN7470	0°C to 70°C
Storage temperature range	– 65°C to 150°C

NOTE 1: All voltage values are with respect to network ground terminal.

recommended operating conditions

			SN5470			SN7470			UNIT		
			MIN	NOM	MAX	MIN	NOM	MAX			
V _{CC}	Supply voltage		4.5	5	5.5	4.75	5	5.25	V		
V _{IH}	High-level input voltage		2			2			V		
V _{IL}	Low-level input voltage				0.8			0.8	V		
I _{OH}	High-level output current				− 0.4			− 0.4	mA		
I _{OL}	Low-level output current				16			16	mA		
t _w	Pulse duration	CLK high	20			20			ns		
		CLK low	30			30					
		PRE or CLR low	25			25					
t _{su}	Setup time before CLK ↑		20			20			ns		
t _h	Hold time-Data after CLK ↑		5			5			ns		
T _A	Operating free-air temperature		− 55			125			0	70	°C

† The arrow indicates the edge of the clock pulse used for reference: † for the rising edge, ‡ for the falling edge.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†	SN5470			SN7470			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		$V_{CC} = \text{MIN}, I_I = -12 \text{ mA}$			– 1.5			– 1.5	V
V_{OH}		$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OH} = -0.4 \text{ mA}$	2.4	3.4		2.4	3.4		V
V_{OL}		$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OL} = 16 \text{ mA}$		0.2	0.4		0.2	0.4	V
I_I		$V_{CC} = \text{MAX}, V_I = 5.5 \text{ V}$			1			1	mA
I_{IH}	PRE or CLR	$V_{CC} = \text{MAX}, V_I = 2.4 \text{ V}$			80			80	μA
	All other				40			40	
I_{IL}	PRE or CLR†	$V_{CC} = \text{MAX}, V_I = 0.4 \text{ V}$			– 3.2			– 3.2	mA
	All other				– 1.6			– 1.6	
$I_{OS}§$		$V_{CC} = \text{MAX}$	– 20		– 57	– 18		– 57	mA
I_{CC}		$V_{CC} = \text{MAX}, \text{ See Note 2}$		13	26		13	26	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$.

§ Not more than one output should be shorted at a time.

† Clear is tested with preset high and preset is tested with clear high.

NOTE 2: With all outputs open, I_{CC} is measured with the Q and \bar{Q} outputs high in turn. At the time of measurement, the clock input is at 4.5 V.

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SN5470, SN7470
AND-GATED J-K POSITIVE-EDGE-TRIGGERED
FLIP-FLOPS WITH PRESET AND CLEAR

switching characteristics, $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$ (see note 3)

PARAMETER†	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f _{max}			R _L = 400 Ω, C _L = 15 pF	20	35		MHz
t _{PLH}	PRE or CLR	Q or Q̄				50	ns
t _{PHL}						50	ns
t _{PLH}	CLK	Q or Q̄			27	50	ns
t _{PHL}						18	50

† f_{\max} = maximum clock frequency; t_{PLH} = propagation delay time, low-to-high level output;

t_{PHL} = propagation delay time, high-to-low level output.

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



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